



# 1.8V, *micro*POWER CMOS OPERATIONAL AMPLIFIERS Zerø-Drift Series

### FEATURES

- LOW OFFSET VOLTAGE: 10µV (max)
- ZERO DRIFT: 0.05µV/°C (max)
- 0.01Hz to 10Hz NOISE:  $1.1\mu V_{PP}$
- QUIESCENT CURRENT: 17µA
- SINGLE-SUPPLY OPERATION
- SUPPLY VOLTAGE: 1.8V to 5.5V
- RAIL-TO-RAIL INPUT/OUTPUT
- microSIZE PACKAGES: SC70 and SOT23

## **APPLICATIONS**

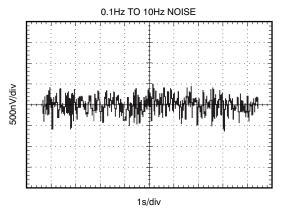
- TRANSDUCER APPLICATIONS
- TEMPERATURE MEASUREMENTS
- ELECTRONIC SCALES
- MEDICAL INSTRUMENTATION
- BATTERY-POWERED INSTRUMENTS
- HANDHELD TEST EQUIPMENT

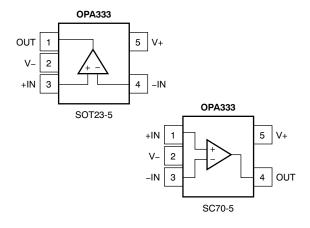


The OPA333 series of CMOS operational amplifiers uses a proprietary auto-calibration technique to simultaneously provide very low offset voltage ( $10\mu$ V max) and near-zero drift over time and temperature. These miniature, high-precision, low quiescent current amplifiers offer high-impedance inputs that have a common-mode range 100mV beyond the rails and rail-to-rail output that swings within 50mV of the rails. Single or dual supplies as low as +1.8V ( $\pm 0.9$ V) and up to +5.5V ( $\pm 2.75$ V) may be used. They are optimized for low-voltage, single-supply operation.

The OPA333 family offers excellent CMRR without the crossover associated with traditional complementary input stages. This design results in superior performance for driving analog-to-digital converters (ADCs) without degradation of differential linearity.

The OPA333 (single version) is available in the SC70-5, SOT23-5, and SO-8 packages. The OPA2333 (dual version) is offered in DFN-8 (3mm  $\times$  3mm), MSOP-8, and SO-8 packages. All versions are specified for operation from -40°C to +125°C.





**A** 

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

## OPA333 OPA2333



#### SBOS351C-MARCH 2006-REVISED MAY 2007

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.



ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

	ORDERING INFORMATION <sup>(1)</sup>								
PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING						
	SOT23-5	DBV	OAXQ						
OPA333	SC70-5	DCK	BQY						
	SO-8	D	O333A						
	SO-8	D	O2333A						
OPA2333	DFN-8	DRB	BQZ						
	MSOP-8	DGK	OBAQ						

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

	OPA333, OPA2333	UNIT
Supply Voltage	+7	V
Signal Input Terminals, Voltage <sup>(2)</sup>	-0.3 to (V+) + 0.3	V
Signal Input Terminals, Voltage <sup>(2)</sup>	±10	mA
Output Short-Circuit <sup>(3)</sup>	Continuous	
Operating Temperature	-40 to +150	°C
Storage Temperature	-65 to +150	۵°
Junction Temperature	+150	°C
ESD Ratings:		
Human Body Model (HBM)	4000	V
Charged Device Model (CDM)	1000	V
Machine Model (MM)	400	V

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

(2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3V beyond the supply rails should be current limited to 10mA or less.

(3) Short-circuit to ground, one amplifier per package.

## ELECTRICAL CHARACTERISTICS: $V_s = +1.8V$ to +5.5V

**Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ . At  $T_A = +25^{\circ}C$ ,  $R_L = 10k\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

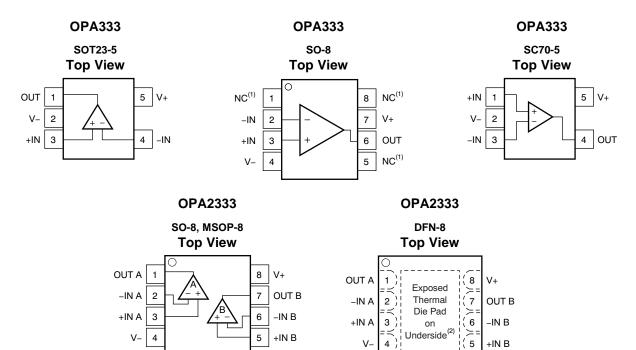
PARAMETER					
	TEST CONDITIONS		TYP	MAX	UNIT
	$V_S = +5V$				μV
					µV/∘C
PSRR	V <sub>S</sub> = +1.8V to +5.5V			5	μ٧/٧
			0.1		μV/V
Ι <sub>Β</sub>			±70	±200	pА
			±150		pА
I <sub>OS</sub>			±140	±400	pА
			0.3		$\mu V_{PP}$
			1.1		$\mu V_{PP}$
i <sub>n</sub>			100		fA/√Hz
$V_{CM}$		(V–) – 0.1		(V+) + 0.1	V
CMRR	$(V-) - 0.1V < V_{CM} < (V+) + 0.1V$	106	130		dB
			2		pF
			4		pF
A <sub>OL</sub>	(V–) + 100mV < V <sub>0</sub> < (V+) – 100mV, R <sub>L</sub> = $10k\Omega$	106	130		dB
GBW	$C_L = 100 pF$		350		kHz
SR	G = +1		0.16		V/µs
	$R_L = 10k\Omega$		30	50	mV
	$R_L = 10k\Omega$			70	mV
I <sub>SC</sub>			±5		mA
CL		See T	pical Charac	teristics	
	f = 350kHz, I <sub>O</sub> = 0		2		kΩ
Vs		1.8		5.5	V
	I <sub>O</sub> = 0		17	25	μA
_				28	μA
	V <sub>S</sub> = +5V		100		μs
	-				•
		-40		+125	°C
		-40		+150	°C
		-65			°C
θιλ					°C/W
AL~			200		°C/W
			150		°C/W
1					
			50		°C/W
	I <sub>OS</sub> in V <sub>CM</sub> CMRR CMRR GBW SR	$ \begin{array}{c c} dV_{OS}/dT \\ PSRR \\ & \\ V_{S} = +1.8V \text{ to } +5.5V \\ \hline \\ & \\ & \\ & \\ & \\ & \\ & \\ & \\ & \\ &$	$\begin{array}{ c c c c } \hline \text{TEST CONDITIONS} & \hline \text{MIN} \\ \hline \text{V}_{OS} & V_{S} = +5V & V_{S} \\ \hline \text{dV}_{OS}/dT & V_{S} = +1.8V to +5.5V & \hline \\ \hline \text{PSRR} & V_{S} = +1.8V to +5.5V & \hline \\ \hline \text{l}_{B} & & & \hline \\ \hline \text{l}_{S} & & & \hline \\ \hline \text{l}_{OS} & & & \hline \\ \hline \text{l}_{OS} & & & \hline \\ \hline \text{l}_{OS} & & & \hline \\ \hline \text{V}_{CM} & & & & \hline \\ \hline \text{V}_{CM} & (V-) - 0.1V < V_{CM} < (V+) + 0.1V & \hline \\ \hline \text{CMRR} & (V-) - 0.1V < V_{CM} < (V+) + 0.1V & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{Q}_{CL} & & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{Q}_{CM} & & \hline \\ \hline \text{Q}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \hline \text{V}_{CM} & & \hline \\ \hline \text{CMRR} & & \hline \\ \text$	$\begin{array}{ c c c c c } \hline \mbox{TEST CONDITIONS} & \mbox{MIN} & \mbox{TYP} \\ \hline \mbox{V}_{OS} & \mbox{V}_{S} = +5V & 2 & 0.02 & 0$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

(1) 300-hour life test at +150°C demonstrated randomly distributed variation of approximately 1µV.

## OPA333 OPA2333

#### SBOS351C-MARCH 2006-REVISED MAY 2007

#### **PIN CONFIGURATIONS**

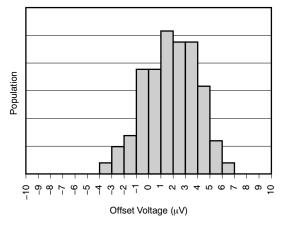


- 1. NC denotes no internal connection.
- 2. Connect thermal die pad to V-.

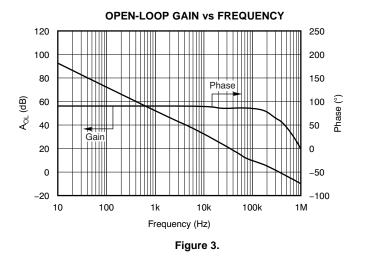
### **TYPICAL CHARACTERISTICS**

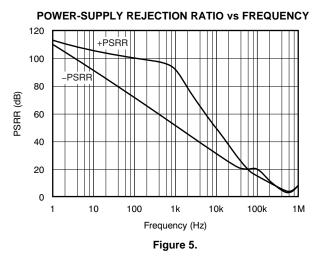
At  $T_A = +25^{\circ}C$ ,  $V_S = +5V$ , and  $C_L = 0pF$ , unless otherwise noted.

#### OFFSET VOLTAGE PRODUCTION DISTRIBUTION

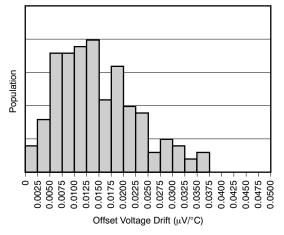


#### Figure 1.



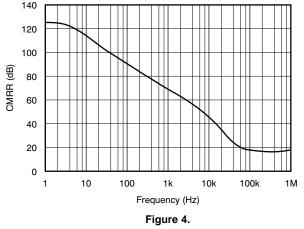


#### OFFSET VOLTAGE DRIFT PRODUCTION DISTRIBUTION

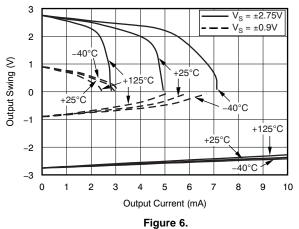




#### COMMON-MODE REJECTION RATIO vs FREQUENCY



**OUTPUT VOLTAGE SWING vs OUTPUT CURRENT** 



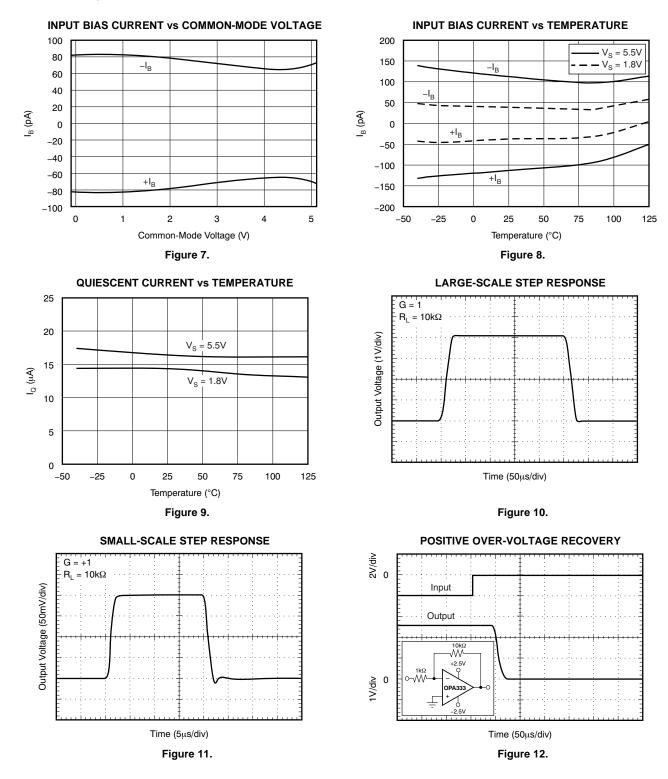
## OPA333 OPA2333



#### SBOS351C-MARCH 2006-REVISED MAY 2007

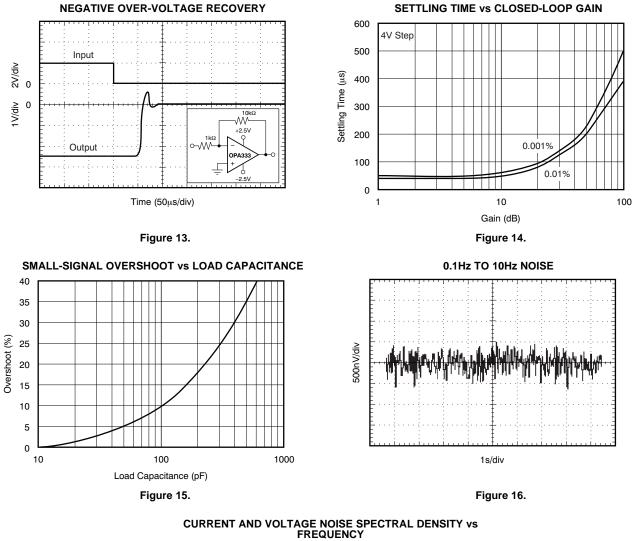
### **TYPICAL CHARACTERISTICS (continued)**

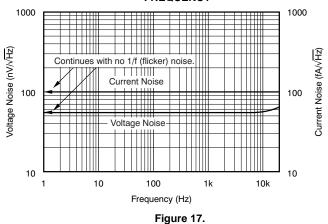
At  $T_A = +25^{\circ}C$ ,  $V_S = +5V$ , and  $C_L = 0pF$ , unless otherwise noted.



### **TYPICAL CHARACTERISTICS (continued)**

At  $T_A = +25^{\circ}C$ ,  $V_S = +5V$ , and  $C_L = 0pF$ , unless otherwise noted.







### **APPLICATIONS INFORMATION**

The OPA333 and OPA2333 are unity-gain stable and free from unexpected output phase reversal. They use a proprietary auto-calibration technique to provide low offset voltage and very low drift over time and temperature. For lowest offset voltage and precision performance, circuit layout and mechanical conditions should be optimized. Avoid temperature gradients that create thermoelectric (Seebeck) effects in the thermocouple junctions formed from dissimilar conductors. connecting These thermally-generated potentials can be made to cancel by assuring they are equal on both input terminals. Other layout and design considerations include:

- Use low thermoelectric-coefficient conditions (avoid dissimilar metals).
- Thermally isolate components from power supplies or other heat sources.
- Shield op amp and input circuitry from air currents, such as cooling fans.

Following these guidelines will reduce the likelihood of junctions being at different temperatures, which can cause thermoelectric voltages of  $0.1\mu$ V/°C or higher, depending on materials used.

### **OPERATING VOLTAGE**

The OPA333 and OPA2333 op amps operate over a power-supply range of +1.8V to +5.5V ( $\pm 0.9V$  to  $\pm 2.75V$ ). Supply voltages higher than +7V (absolute maximum) can permanently damage the device. Parameters that vary over supply voltage or temperature are shown in the Typical Characteristics section of this data sheet.

### INPUT VOLTAGE

The OPA333 and OPA2333 input common-mode voltage range extends 0.1V beyond the supply rails. The OPA333 is designed to cover the full range without the troublesome transition region found in some other rail-to-rail amplifiers.

Normally, input bias current is about 70pA; however, input voltages exceeding the power supplies can cause excessive current to flow into or out of the input pins. Momentary voltages greater than the power supply can be tolerated if the input current is limited to 10mA. This limitation is easily accomplished with an input resistor, as shown in Figure 18.

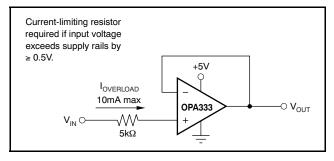


Figure 18. Input Current Protection

### **INTERNAL OFFSET CORRECTION**

The OPA333 and OPA2333 op amps use an auto-calibration technique with a time-continuous 350kHz op amp in the signal path. This amplifier is zero-corrected every 8 $\mu$ s using a proprietary technique. Upon power-up, the amplifier requires approximately 100 $\mu$ s to achieve specified V<sub>OS</sub> accuracy. This design has no aliasing or flicker noise.

### ACHIEVING OUTPUT SWING TO THE OP AMP NEGATIVE RAIL

Some applications require output voltage swings from 0V to a positive full-scale voltage (such as +2.5V) with excellent accuracy. With most single-supply op amps, problems arise when the output signal approaches 0V, near the lower output swing limit of a single-supply op amp. A good single-supply op amp may swing close to single-supply ground, but will not reach ground. The output of the OPA333 and OPA2333 can be made to swing to ground, or slightly below, on a single-supply power source. To do so requires the use of another resistor and an additional, more negative, power supply than the op amp negative supply. A pull-down resistor may be connected between the output and the additional negative supply to pull the output down below the value that the output would otherwise achieve, as shown in Figure 19.

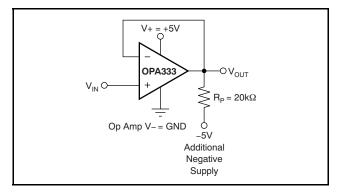


Figure 19. For V<sub>OUT</sub> Range to Ground

The OPA333 and OPA2333 have an output stage that allows the output voltage to be pulled to its negative supply rail, or slightly below, using the technique previously described. This technique only works with some types of output stages. The OPA333 and OPA2333 have been characterized to perform with this technique; the recommended resistor value is approximately  $20k\Omega$ . Note that this configuration will increase the current consumption by several hundreds of microamps. Accuracy is excellent down to 0V and as low as -2mV. Limiting and nonlinearity occurs below -2mV, but excellent accuracy returns as the output is again driven above -2mV. Lowering the resistance of the pull-down resistor will allow the op amp to swing even further below the negative rail. Resistances as low as  $10k\Omega$  can be used to achieve excellent accuracy down to -10mV.

### **GENERAL LAYOUT GUIDELINES**

Attention to good layout practices is always recommended. Keep traces short and, when possible, use a printed circuit board (PCB) ground plane with surface-mount components placed as close to the device pins as possible. Place a  $0.1\mu$ F capacitor closely across the supply pins. These guidelines should be applied throughout the analog circuit to improve performance and provide benefits such as reducing the EMI (electromagnetic-interference) susceptibility.

Operational amplifiers vary in their susceptibility to radio frequency interference (RFI). RFI can generally be identified as a variation in offset voltage or dc signal levels with changes in the interfering RF signal. The OPA333 has been specifically designed to minimize susceptibility to RFI and demonstrates remarkably low sensitivity compared to previous generation devices. Strong RF fields may still cause varying offset levels.

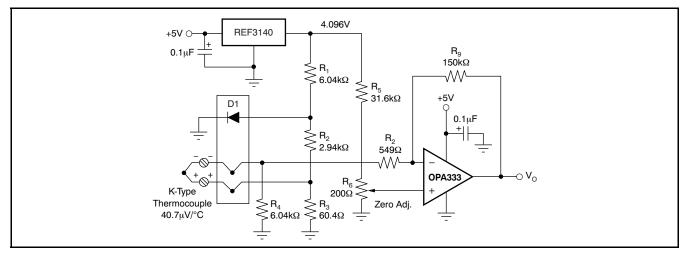


Figure 20. Temperature Measurement

## OPA333 OPA2333



#### SBOS351C-MARCH 2006-REVISED MAY 2007

Figure 21 shows the basic configuration for a bridge amplifier.

A low-side current shunt monitor is shown in Figure 22.  $R_N$  are operational resistors used to isolate the ADS1100 from the noise of the digital I<sup>2</sup>C bus. Since the ADS1100 is a 16-bit converter, a precise reference is essential for maximum accuracy. If absolute accuracy is not required, and the 5V power supply is sufficiently stable, the REF3130 may be omitted.

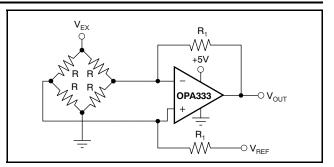


Figure 21. Single Op Amp Bridge Amplifier

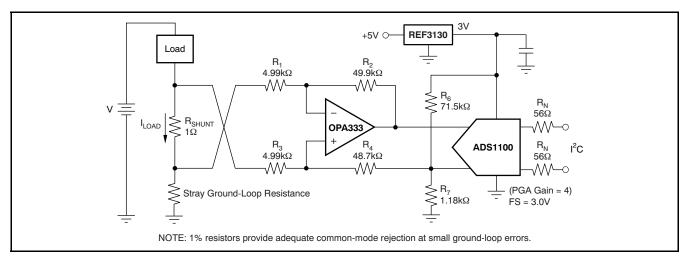


Figure 22. Low-Side Current Monitor

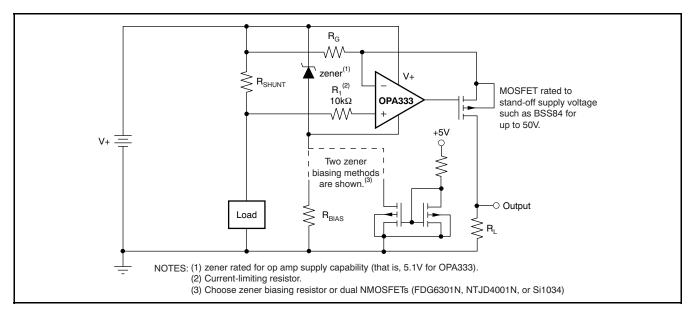


Figure 23. High-Side Current Monitor

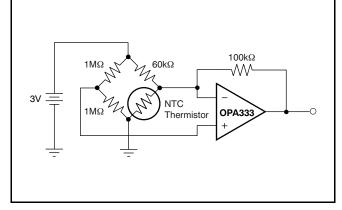
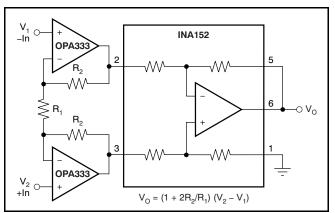


Figure 24. Thermistor Measurement





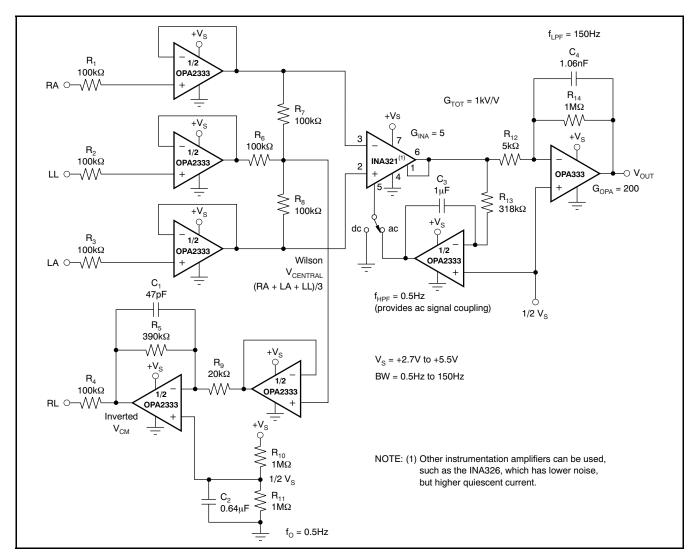


Figure 26. Single-Supply, Very Low Power, ECG Circuit

#### DFN PACKAGE

The OPA2333 is offered in an DFN-8 package (also known as SON). The DFN is a QFN package with lead contacts on only two sides of the bottom of the package. This leadless package maximizes board space and enhances thermal and electrical characteristics through an exposed pad.

DFN packages are physically small, have a smaller routing area, improved thermal performance, and improved electrical parasitics. Additionally, the absence of external leads eliminates bent-lead issues.

The DFN package can be easily mounted using standard printed circuit board (PCB) assembly techniques. See Application Note *QFN/SON PCB Attachment* (SLUA271) and Application Report *Quad Flatpack No-Lead Logic Packages* (SCBA017), both available for download at www.ti.com.

The exposed leadframe die pad on the bottom of the package should be connected to V- or left unconnected.

### DFN LAYOUT GUIDELINES

The exposed leadframe die pad on the DFN package should be soldered to a thermal pad on the PCB. A mechanical drawing showing an example layout is attached at the end of this data sheet. Refinements to this layout may be necessary based on assembly process requirements. Mechanical drawings located at the end of this data sheet list the physical dimensions for the package and pad. The five holes in the landing pattern are optional, and are intended for use with thermal vias that connect the leadframe die pad to the heatsink area on the PCB.

TEXAS STRUMENTS www.ti.com

Soldering the exposed pad significantly improves board-level reliability during temperature cycling, key push, package shear, and similar board-level tests. Even with applications that have low-power dissipation, the exposed pad must be soldered to the PCB to provide structural integrity and long-term reliability.



9-Jul-2013

## **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
OPA2333AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O2333A	Samples
OPA2333AIDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O2333A	Samples
OPA2333AIDGKR	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	OBAQ	Samples
OPA2333AIDGKRG4	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	OBAQ	Samples
OPA2333AIDGKT	ACTIVE	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	OBAQ	Samples
OPA2333AIDGKTG4	ACTIVE	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	OBAQ	Samples
OPA2333AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O2333A	Samples
OPA2333AIDRBR	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BQZ	Samples
OPA2333AIDRBRG4	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BQZ	Samples
OPA2333AIDRBT	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BQZ	Samples
OPA2333AIDRBTG4	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BQZ	Samples
OPA2333AIDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O2333A	Samples
OPA333AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 0	O333A	Samples
OPA333AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	OAXQ	Samples
OPA333AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	OAXQ	Samples
OPA333AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	OAXQ	Samples
OPA333AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	OAXQ	Samples



9-Jul-2013

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
OPA333AIDCKR	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQY	Samples
OPA333AIDCKRG4	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQY	Samples
OPA333AIDCKT	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQY	Samples
OPA333AIDCKTG4	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQY	Samples
OPA333AIDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O333A	Samples
OPA333AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O333A	Samples
OPA333AIDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	O333A	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



www.ti.com

9-Jul-2013

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF OPA2333, OPA333 :

• Automotive: OPA2333-Q1, OPA333-Q1

NOTE: Qualified Version Definitions:

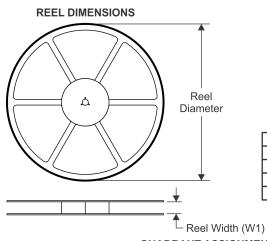
• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## PACKAGE MATERIALS INFORMATION

www.ti.com

Texas Instruments

### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA2333AIDGKT	VSSOP	DGK	8	250	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2333AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA2333AIDRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2333AIDRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA333AIDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
OPA333AIDCKR	SC70	DCK	5	3000	179.0	8.4	2.2	2.5	1.2	4.0	8.0	Q3
OPA333AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TEXAS INSTRUMENTS

www.ti.com

## PACKAGE MATERIALS INFORMATION

19-Jul-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA2333AIDGKT	VSSOP	DGK	8	250	364.0	364.0	27.0
OPA2333AIDR	SOIC	D	8	2500	367.0	367.0	35.0
OPA2333AIDRBR	SON	DRB	8	3000	367.0	367.0	35.0
OPA2333AIDRBT	SON	DRB	8	250	210.0	185.0	35.0
OPA333AIDBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
OPA333AIDCKR	SC70	DCK	5	3000	203.0	203.0	35.0
OPA333AIDR	SOIC	D	8	2500	367.0	367.0	35.0

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

D. Falls within JEDEC MO-178 Variation AA.



DBV (R-PDSO-G5)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.

- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-203 variation AA.



## LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.

- D Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Small Outline No-Lead (SON) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.



## THERMAL PAD MECHANICAL DATA

## DRB (S-PVSON-N8)

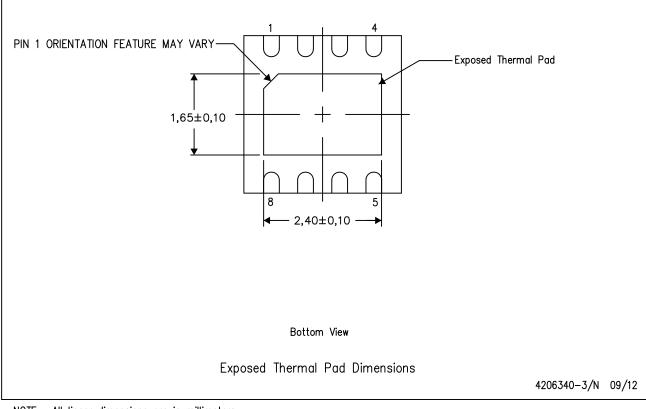
## PLASTIC SMALL OUTLINE NO-LEAD

### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

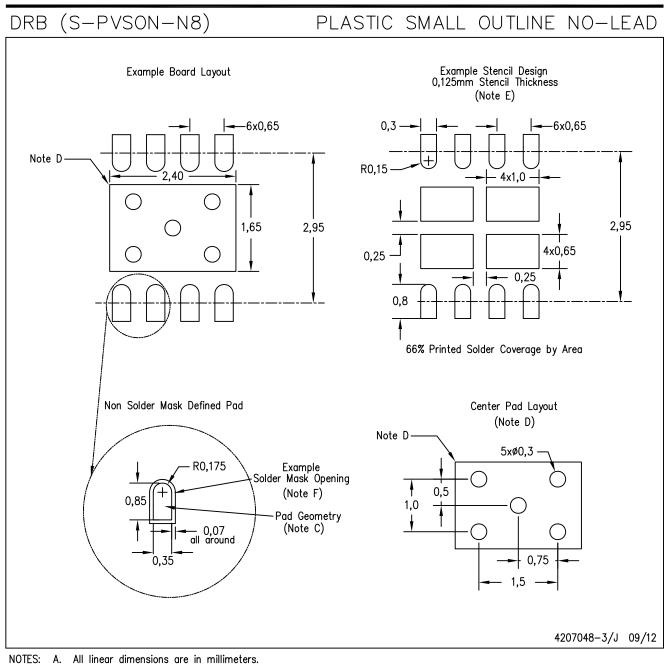
For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters





- This drawing is subject to change without notice. Β.
  - Publication IPC-7351 is recommended for alternate designs. C.

  - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - F. Customers should contact their board fabrication site for solder mask tolerances.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconne	ectivity	

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2013, Texas Instruments Incorporated